Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/718,817	KIM ET AL.	
Examiner	Art Unit	

ALI ALLAWI

2877

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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See Sear	ch History				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
searched class subclass 356/237.15, 331-334, 250/559.01-559.08, 382/141-145, 348/86,87,92	2/23/2006	AA		
text search of dispersion, diffraction, prism grating, calibration, standards, reference and periphery	2/23/2006	AA		
calibration standard, reference, periphery, superposition, combine, and image	3/6/2006	AA		
Consulted with primaries Rosenberger and Stafira and examiner Geisel about allowable subject matter	3/6/2006	AA		